

FEATURES

Access time: 55 nsLow power consumption:

Operating current : 30/20mA (TYP.) Standby current : 4 µA (TYP.) C-version

■ Single $2.7V \sim 5.5V$ power supply

■ Fully Compatible with all Competitors 5V product

■ Fully Compatible with all Competitors 3.3V product

■ Fully static operation

■ Tri-state output

■ Data retention voltage : 2.0V (MIN.)

All products ROHS Compliant

■ Package 32-pin 450 mil SOP

32-pin 8mm x 20mm TSOP-I

32-pin 600 mil P-DIP

32-pin 8mm x 13.4mm sTSOP

*36-ball 6mm x 8mm TFBGA

Coming Soon!

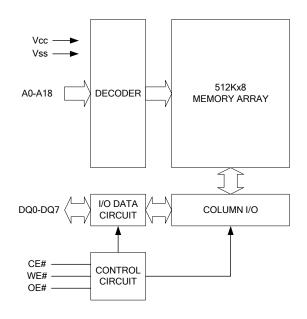
GENERAL DESCRIPTION

The AS6C4008 is a 4,194,304-bit low power CMOS static random access memory organized as 524,288 words by 8 bits. It is fabricated using very high performance, high reliability CMOS technology. Its standby current is stable within the range of operating temperature.

The AS6C4008 is well designed for very low power system applications, and particularly well suited for battery back-up non-volatile memory application.

The AS6C4008 operates from a single power supply of $2.7V \sim 5.5V$

FUNCTIONAL BLOCK DIAGRAM

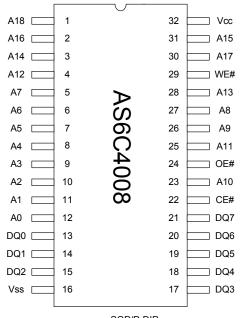


PIN DESCRIPTION**

SYMBOL	DESCRIPTION
A0 - A18	Address Inputs
DQ0 – DQ7	Data Inputs/Outputs
CE#	Chip Enable Inputs
WE#	Write Enable Input
OE#	Output Enable Input
Vcc	Power Supply
Vss	Ground
NC	No Connection

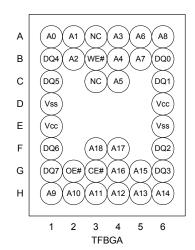


PIN CONFIGURATION





SOP/P-DIP





ABSOLUTE MAXIMUM RATINGS*

OCTOBER 2007

PARAMETER	SYMBOL	RATING	UNIT
Terminal Voltage with Respect to Vss	VTERM	-0.5 to 6.5	V
		0 to 70(C grade)	
Operating Temperature	TA		°C
		-40 to 85(I grade)	C
Storage Temperature	Тѕтс	-65 to 150	°C
Power Dissipation	PD	1	W
DC Output Current	Іоит	50	mA
Soldering Temperature (under 10 sec)	Tsolder	260	°C

^{*}Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to the absolute maximum rating conditions for extended period may affect device reliability.

TRUTH TABLE

MODE	CE#	OE#	WE#	I/O OPERATION	SUPPLY CURRENT
Standby	Н	Х	Х	High-Z	I _{SB1}
Output Disable	L	Н	Н	High-Z	Icc,Icc1
Read	L	L	Н	Dout	lcc,lcc1
Write	L	Х	L	Din	Icc,Icc1

Note: H = VIH, L = VIL, X = Don't care.

DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION		MIN.	TYP. *3	MAX.	UNIT
Supply Voltage	Vcc			2.7	3.0	5.5	V
Input High Voltage	V _{IH} *1			0.7* Vcc	-	Vcc+0.3	V
Input Low Voltage	V _{IL} *1			- 0.2	-	0.6	V
Input Leakage Current	ILI	$V_{CC} \ge V_{IN} \ge V_{SS}$		- 1	-	1	μA
Output Leakage Current	ILO	$V_{CC} \ge V_{OUT} \ge V_{SS},$ Output Disabled		- 1	-	1	μA
Output High Voltage	Vон	Iон = -1mA		2.4	-	-	V
Output Low Voltage	Vol	I _{OL} = 2mA		-	-	0.4	V
	Icc	Cycle time = Min. CE# = $0.2V$, I_{VO} = 0 mA	- 55	-	30	60	mA
Average Operating		other pins at 0.2V or Vcc - 0.2V	,				
Power supply Current	Icc1	Cycle time = 1μ s CE# = 0.2V, $I_{I/O}$ = 0mA other pins at 0.2V or V_{CC} - 0.2\	/	-	4	10	mA
Standby Power Supply Current	I _{SB1}	CE# ≧Vcc - 0.2V		-	4	50 ^{*4} 50 ^{*4}	μA μA

Notes: 1. VIH(max) = Vcc + 3.0V for pulse width less than 10ns. VIL(min) = Vss - 3.0V for pulse width less than 10ns.

^{2.} Over/Undershoot specifications are characterized, not 100% tested.

^{3.} Typical values are included for reference only and are not guaranteed or tested.

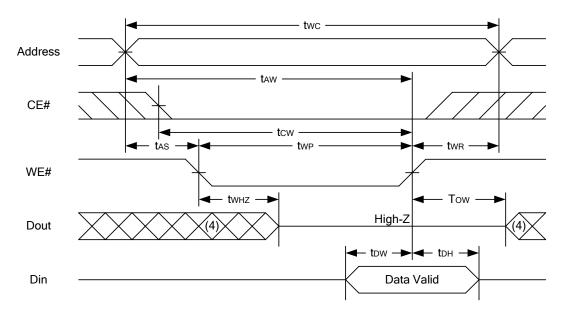
Typical valued are measured at Vcc = Vcc(TYP.) and TA = 25°C

^{4.} $25\mu A$ for special request

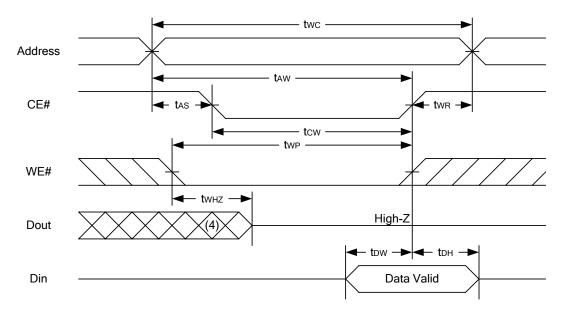
^{*}C=Commercial temperature/I = Industrial temperature



WRITE CYCLE 1 (WE# Controlled) (1,2,3,5,6)



WRITE CYCLE 2 (CE# Controlled) (1,2,5,6)



Notes

- 1.WE#, CE# must be high during all address transitions.
- 2.A write occurs during the overlap of a low CE#, low WE#.
- 3.During a WE# controlled write cycle with OE# low, twp must be greater than twHz + tpw to allow the drivers to turn off and data to be placed on the bus.
- 4. During this period, I/O pins are in the output state, and input signals must not be applied.
- 5.If the CE# low transition occurs simultaneously with or after WE# low transition, the outputs remain in a high impedance state.
- 6.tow and twHz are specified with CL = 5pF. Transition is measured $\pm 500mV$ from steady state.

OCTOBER 2007 AS6C4008

Rev. 1.1

512K X 8 BIT LOW POWER CMOS SRAM

Notes:

- 1. $V_{IH}(max) = V_{CC} + 3.0V$ for pulse width less than 10ns.
- 2. VIL(min) = Vss 3.0V for pulse width less than 10ns.
- 3. Over/Undershoot specifications are characterized, not 100% tested.
- 4. Typical values are included for reference only and are not guaranteed or tested. Typical valued are measured at Vcc = Vcc(TYP.) and TA = 25?

CAPACITANCE (TA = 25° C, f = 1.0MHz)

PARAMETER	SYMBOL	MIN.	MAX	UNIT
Input Capacitance	Cin	-	6	pF
Input/Output Capacitance	Ci/o	-	8	pF

Note: These parameters are guaranteed by device characterization, but not production tested.

AC TEST CONDITIONS

Input Pulse Levels	0.2V to Vcc - 0.2V
Input Rise and Fall Times	3ns
Input and Output Timing Reference Levels	1.5V
Output Load	$C_L = 30pF + 1TTL$, $I_{OH}/I_{OL} = -1mA/2mA$

AC ELECTRICAL CHARACTERISTICS

(1) READ CYCLE

PARAMETER	SYM.	AS6C4008-55			UNIT			
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
Read Cycle Time	t RC			55	-			ns
Address Access Time	taa			-	55			ns
Chip Enable Access Time	tace			-	55			ns
Output Enable Access Time	toe			-	30			ns
Chip Enable to Output in Low-Z	tcLz*			10	-			ns
Output Enable to Output in Low-Z	tolz*			5	-			ns
Chip Disable to Output in High-Z	tcHz*			-	20			ns
Output Disable to Output in High-Z	tonz*			-	20			ns
Output Hold from Address Change	tон			10	-			ns

(2) WRITE CYCLE

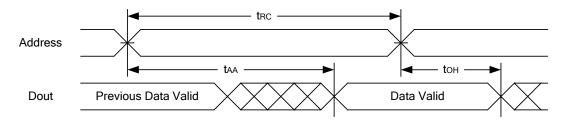
PARAMETER	SYM.			AS6C4	008-55			UNIT
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
Write Cycle Time	twc			55	-			ns
Address Valid to End of Write	taw			50	-			ns
Chip Enable to End of Write	tcw			50	-			ns
Address Set-up Time	tas			0	-			ns
Write Pulse Width	twp			45	-			ns
Write Recovery Time	twr			0	-			ns
Data to Write Time Overlap	tow			25	-			ns
Data Hold from End of Write Time	tон			0	-			ns
Output Active from End of Write	tow*			5	-			ns
Write to Output in High-Z	twnz*			-	20			ns

^{*}These parameters are guaranteed by device characterization, but not production tested.

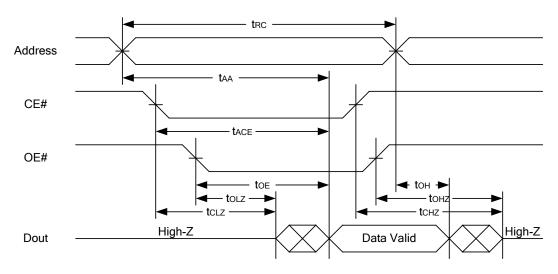


TIMING WAVEFORMS

READ CYCLE 1 (Address Controlled) (1,2)



READ CYCLE 2 (CE# and OE# Controlled) (1,3,4,5)

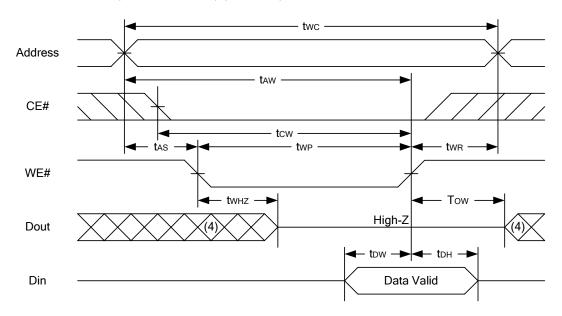


Notes:

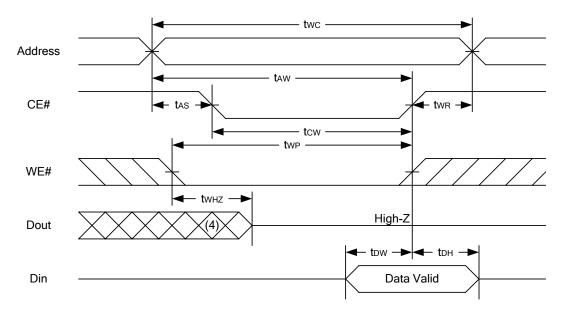
- 1.WE# is high for read cycle.
- 2.Device is continuously selected OE# = low, CE# = low.
- 3.Address must be valid prior to or coincident with CE# = low,; otherwise tAA is the limiting parameter.
- 4.tclz, tolz, tchz and tohz are specified with CL = 5pF. Transition is measured ±500mV from steady state.
- $5. At any given temperature and voltage condition, t_{CHZ} is less than t_{CLZ} \,, t_{OHZ} is less than t_{OLZ}.$



WRITE CYCLE 1 (WE# Controlled) (1,2,3,5,6)



WRITE CYCLE 2 (CE# Controlled) (1,2,5,6)



Notes

- 1.WE#, CE# must be high during all address transitions.
- 2.A write occurs during the overlap of a low CE#, low WE#.
- 3.During a WE# controlled write cycle with OE# low, twp must be greater than twHz + tpw to allow the drivers to turn off and data to be placed on the bus.
- 4. During this period, I/O pins are in the output state, and input signals must not be applied.
- 5.If the CE# low transition occurs simultaneously with or after WE# low transition, the outputs remain in a high impedance state.
- 6.tow and twHz are specified with CL = 5pF. Transition is measured $\pm 500mV$ from steady state.

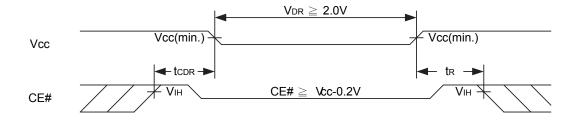


DATA RETENTION CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Vcc for Data Retention	V _{DR}	CE# ≥ V _{CC} - 0.2V	2.0	-	5.5	V
Data Retention Current	I _{DR}	V_{CC} = 2.0V **C $CE\# \ge V_{CC} - 0.2V$ **I	 	2	30 30	μ μA
Chip Disable to Data Retention Time	tcdr	See Data Retention Waveforms (below)	0	-	-	ns
Recovery Time	tr		t RC∗	-	-	ns

trc* = Read Cycle Time **C=Commercial temperature/I=Industrial temperature

DATA RETENTION WAVEFORM

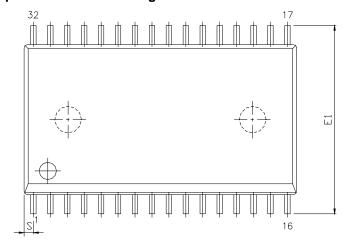


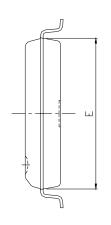


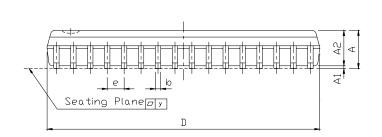


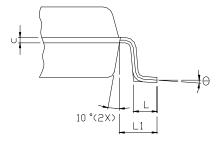
PACKAGE OUTLINE DIMENSION

32 pin 450 mil SOP Package Outline Dimension





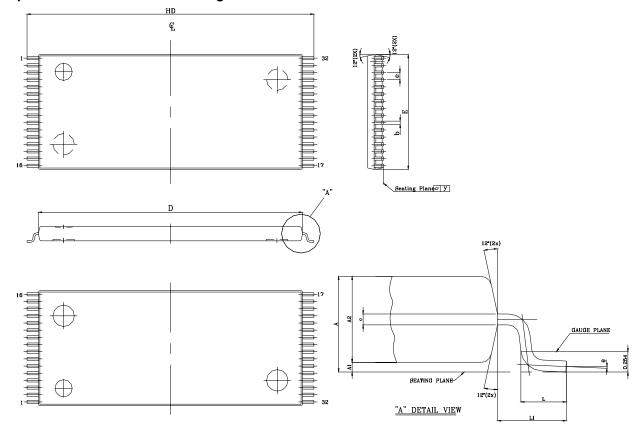




SYM. UNIT	INCH.(BASE)	MM(REF)
Α	0.118 (MAX)	2.997 (MAX)
A1	0.004(MIN)	0.102(MIN)
A2	0.111(MAX)	2.82(MAX)
b	0.016(TYP)	0.406(TYP)
С	0.008(TYP)	0.203(TYP)
D	0.817(MAX)	20.75(MAX)
E	0.445 ±0.005	11.303 ±0.127
E1	0.555 ±0.012	14.097 ±0.305
е	0.050(TYP)	1.270(TYP)
L	0.0347 ±0.008	0.881 ±0.203
L1	0.055 ±0.008	1.397 ±0.203
S	0.026(MAX)	0.660 (MAX)
у	0.004(MAX)	0.101(MAX)
Θ	0° -10°	0° -10°



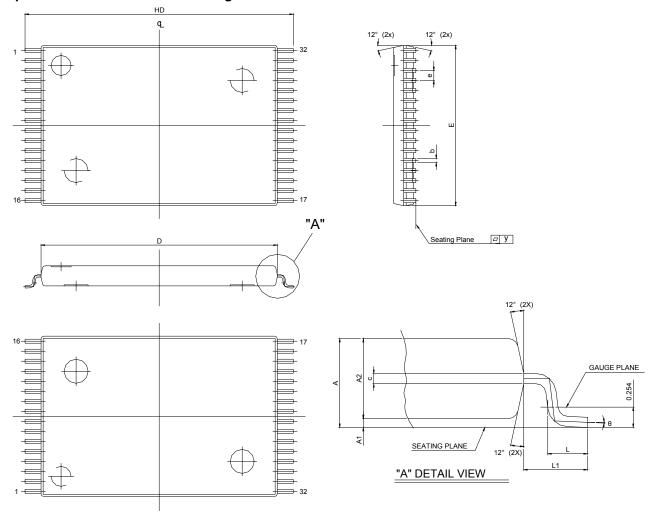
32 pin 8mm x 20mm TSOP-I Package Outline Dimension



SYM. UNIT	INCH(BASE)	MM(REF)
Α	0.047 (MAX)	1.20 (MAX)
A1	0.004 ±0.002	0.10 ±0.05
A2	0.039 ±0.002	1.00 ±0.05
b	0.008 + 0.002	0.20 + 0.05
	- 0.001	-0.03
С	0.005 (TYP)	0.127 (TYP)
D	0.724 ±0.004	18.40 ±0.10
E	0.315 ±0.004	8.00 ±0.10
е	0.020 (TYP)	0.50 (TYP)
HD	0.787 ±0.008	20.00 ±0.20
L	0.0197 ±0.004	0.50 ±0.10
L1	0.0315 ±0.004	0.08 ±0.10
у	0.003 (MAX)	0.076 (MAX)
Θ	0°∼5°	0°∼5°



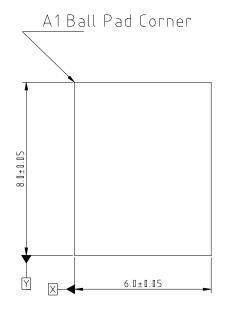
32 pin 8mm x 13.4mm sTSOP Package Outline Dimension

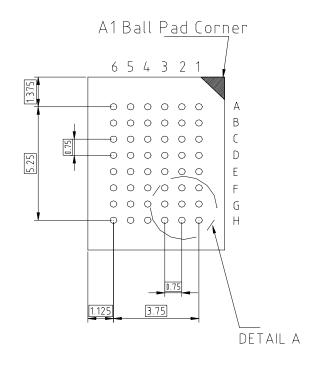


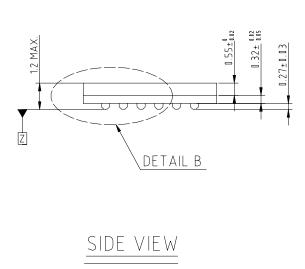
SYM. UNIT	INCH(BASE)	MM(REF)
Α	0.049 (MAX)	1.25 (MAX)
A1	0.005 ±0.002	0.130 ±0.05
A2	0.039 ±0.002	1.00 ±0.05
b	0.008 ±0.01	0.20±0.025
С	0.005 (TYP)	0.127 (TYP)
D	0.465 ±0.004	11.80 ±0.10
E	0.315 ±0.004	8.00 ±0.10
е	0.020 (TYP)	0.50 (TYP)
HD	0.528±0.008	13.40 ±0.20.
L	0.0197 ±0.004	0.50 ±0.10
L1	0.0315 ±0.004	0.8 ±0.10
у	0.003 (MAX)	0.076 (MAX)
Θ	0°∼5°	0°∼5°

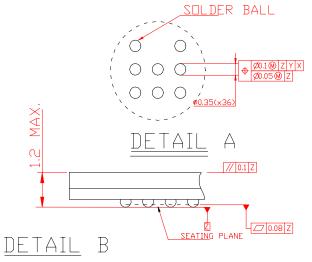


36 ball 6mm × 8mm TFBGA Package Outline Dimension



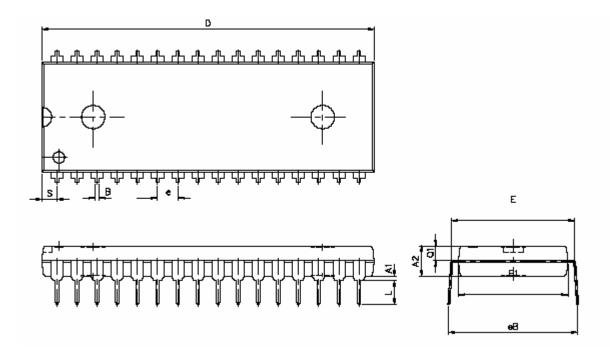








32 pin 600 mil P-DIP Package Outline Dimension



SYM. UNIT	INCH(BASE)) MM(REF)	
A1	0.001 (MIN)	0.254 (MIN)	
A2	0.150 ± 0.005	3.810 ± 0.127	
В	0.018 ± 0.005	0.457 ± 0.127	
D	1.650 ± 0.005	41.910 ± 0.127	
E	0.600 ± 0.010	15.240 ± 0.254	
E1	0.544 ± 0.004	13.818 ± 0.102	
е	0.100 (TYP)	2.540 (TYP)	
eB	0.640 ± 0.020	16.256 ± 0.508.	
L 0.130 ± 0.010 3.3		3.302 ± 0.254	
S	0.075 ± 0.010	1.905 ± 0.254	
Q1	0.070 ± 0.005	1.778 ± 0.127	

Note: D/E1/S dimension do not include mold flash.

ORDERING INFORMATION

Ordering Codes

				Operating	Speed
Alliance	Organization	VCC range	Package	Temp	ns
AS6C4008-55PCN	512k x 8	2.7-5.5V	32pin 600mil PDIP	Commercial ~ 0° C to 70° C	55
AS6C4008-55SIN	512k x 8	2.7-5.5V	32pin 450mil SOP	Industrial ~ -40°C to 85° C	55
AS6C4008-55TIN	512k x 8	2.7-5.5V	32pin TSOP-I (8 x 20 mm)	Industrial ~ -40°C to 85° C	55
AS6C4008-55STIN	512k x 8	2.7-5.5V	32pin sTSOP (8 x 13.4 mm)	Industrial ~ -40°C to 85° C	55
AS6C4008-55BIN	512k x 8	2.7-5.5V	36pin TFBGA (6mm x 8mm) *	Industrial ~ -40°C to 85° C	55
			*Coming Soon!		

Part numbering system

AS6C	4008	- 55	X	X	N
			Package Options: P = 32 pin 600 mil P-DIP S = 32 pin 450 mil SOP	Temperature Range:	
low	Device		T = 32 pin TSOP-I (8mm x 20 mm)	C = Commercial	N = Lead
power	Number		ST = 32 pin sTSOP (8mm x 13.4 mm)	(0°C to +70° C)	Free ROHS
SRAM	40 = 4M	Access	B = 36 pin TFBGA (6mm x 8mm)*	l = hdustrial	Compliant
prefix	08 = by 8	Time	-	(-40° to +85° C)	Part

^{*} Coming Soon!





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